

SPP1433S32RGB-VB Datasheet

P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^c	Q _g (Typ.)			
- 20	0.080 at V _{GS} = - 4.5 V	- 3.1	4.3 nC			
- 20	0.100 at V _{GS} = - 2.5 V	- 2.3	4.5110			

FEATURES

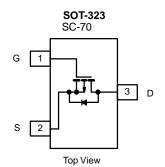
- Halogen-free According to IEC 61249-2-21 Definition
- Trench Power MOSFET
- 100 % R_g Tested
- Compliant to RoHS Directive 2002/95/EC

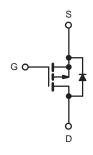


HALOGEN FREE

APPLICATIONS

- Load Switch
- DC/DC Converters





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T_A = 25 °C, unless otherwise noted) **Parameter** Symbol Limit Unit - 20 Drain-Source Voltage V_{DS} ٧ V_{GS} Gate-Source Voltage ± 12 $T_C = 25 \, ^{\circ}C$ - 3.1 $T_C = 70 \, ^{\circ}C$ - 2.1 Continuous Drain Current (T_J = 150 °C) I_D T_A = 25 °C - 1.4^{a, b} $T_A = 70 \, ^{\circ}C$ - 1.1^{a, b} Α I_{DM} **Pulsed Drain Current** - 6 T_C = 25 °C - 0.4 Continuous Source-Drain Diode Current I_S T_A = 25 °C - 0.3 T_C = 25 °C 0.5 T_C = 70 °C 0.3 P_D Maximum Power Dissipation W T_A = 25 °C 0.4^{a, b} T_A = 70 °C 0.3^{a, b} T_J , T_{stg} - 50 to 150 Operating Junction and Storage Temperature Range °С 260 Soldering Recommendations (Peak Temperature)

a. Surface mounted on 1" x 1" FR4 board.

b. t = 10 s.

c. Based on $T_C = 25$ °C.



THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, b}	t ≤ 10 s	R _{thJA}	250	300	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	225	270	C/VV	

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. Maximum under steady state conditions is 360 °C/W.

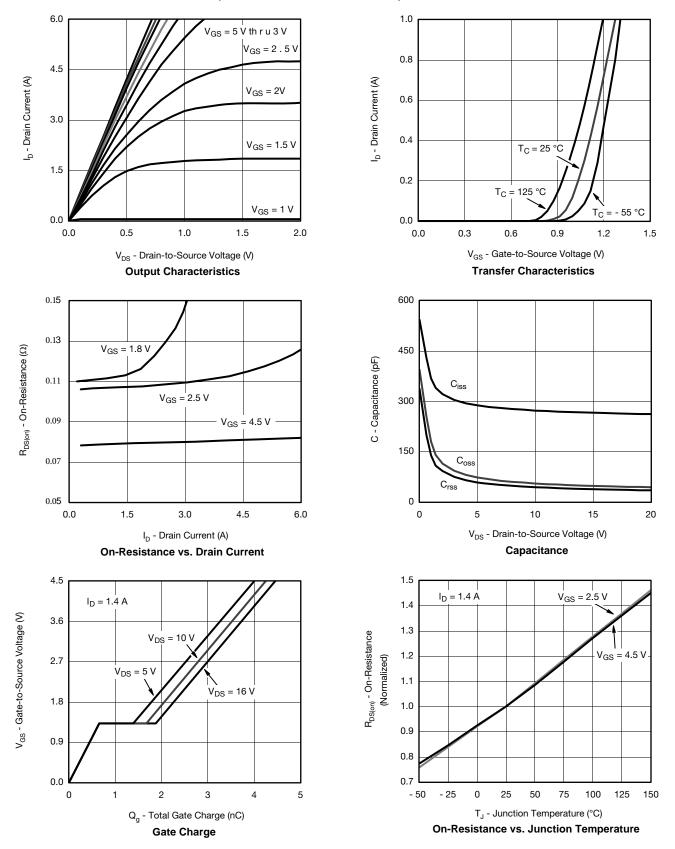
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	- 20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 14		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		2.4			
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.45		- 1.5	V	
Gate-Source Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current		$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}$			- 1	μA	
Zeio Gate voltage Diain Current	I _{DSS}	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 2			Α	
		$V_{GS} = -4.5 \text{ V}, I_D = -1.4 \text{ A}$		0.080			
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -2.5 \text{ V}, I_D = -1.2 \text{ A}$		0.100		Ω	
		V _{GS} = - 1.8 V, I _D = - 0.3 A		0.140			
Forward Transconductance ^a	9 _{fs}	$V_{DS} = -5 \text{ V}, I_{D} = -1.4 \text{ A}$		5		S	
Dynamic ^b							
Input Capacitance	C _{iss}			272		pF	
Output Capacitance	C _{oss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		55			
Reverse Transfer Capacitance	C _{rss}			44			
Total Gate Charge	Q _g	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -1.4 \text{ A}$		4.3	6.5	nC	
Total Gate Charge				2.7	4.1		
Gate-Source Charge		$V_{DS} = -10 \text{ V}, V_{GS} = -2.5 \text{ V}, I_{D} = -1.4 \text{ A}$		0.7			
Gate-Drain Charge	Q_{gd}			1.0			
Gate Resistance	R_g	f = 1 MHz	1.4	7	14	Ω	
Turn-On Delay Time	t _{d(on)}			12	20		
Rise Time	t _r	V_{DD} = - 10 V, R_L = 9.1 Ω		20	30		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong$ - 1.1 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		23	35		
Fall Time	t _f			9	18	ns	
Turn-On Delay Time	t _{d(on)}			5	10	115	
Rise Time	t _r	V_{DD} = - 10 V, R_L = 9.1 Ω		10	20		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -1.1 \text{ A}, V_{GEN} = -8 \text{ V}, R_g = 1 \Omega$		18	27		
Fall Time	t _f			7	14		
Drain-Source Body Diode Characterist	ics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 2.4	A	
Pulse Diode Forward Current ^a	I _{SM}				- 6		
Body Diode Voltage	V _{SD}	I _F = - 0.7 A		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			18	27	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 0.7 A, dl/dt = 100 A/μs, T _{.I} = 25 °C		7	14	nC	
Reverse Recovery Fall Time	t _a	1F = -0.7 A, αι/αι = 100 A/μS, 1J = 25 °C		7		ns	
Reverse Recovery Rise Time	t _b			11			

Notes:

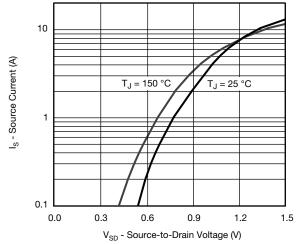
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

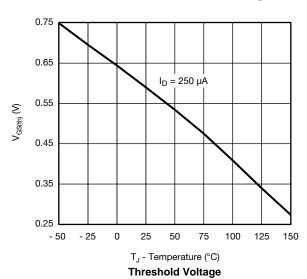








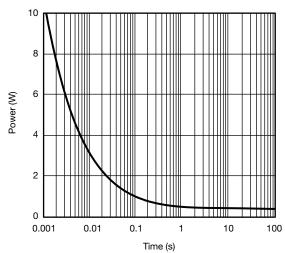
Source-Drain Diode Forward Voltage



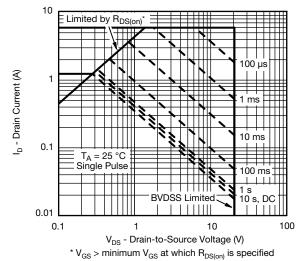
 C_{O}^{C} 0.24 C_{O}^{C} 0.16 C_{O}^{C} 0.08 C_{O}^{C} 0.08 C_{O}^{C} 0.32 C_{O}^{C} 0.16 C_{O}^{C} 0.32 C_{O}^{C} 0.4 C_{O}^{C} 0.4 C_{O}^{C} 0.7 C_{O}^{C} 0.7 C_{O}^{C} 0.8 C_{O}^{C} 0.9 $C_{\text{O}}^{\text{C$

V_{GS} - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage

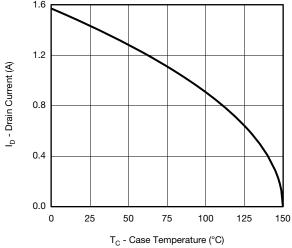


Single Pulse Power, Junction-to-Ambient



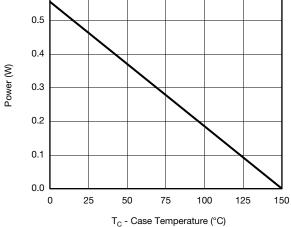
Safe Operating Area, Junction-to-Ambient



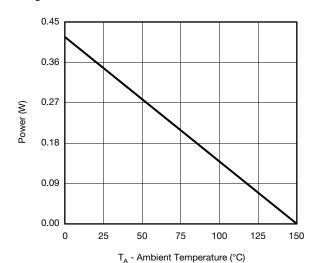


Current Derating*





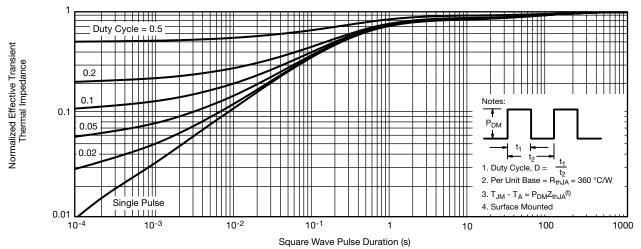
Power, Junction-to-Case



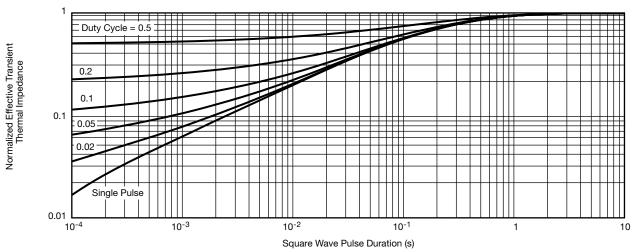
Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





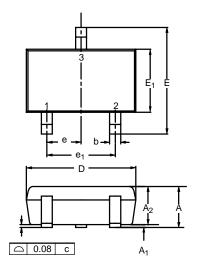
Normalized Thermal Transient Impedance, Junction-to-Ambient

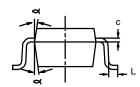


Normalized Thermal Transient Impedance, Junction-to-Foot



SC-70: 3-LEADS

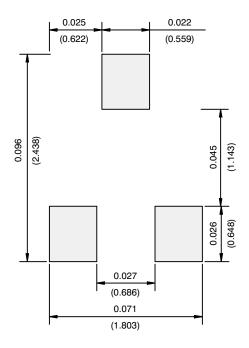




	MIL	LIMET	ERS	INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	0.90	-	1.10	0.035	-	0.043	
A ₁	_	-	0.10	_	_	0.004	
A ₂	0.80	-	1.00	0.031	_	0.039	
b	0.25	-	0.40	0.010	_	0.016	
С	0.10	-	0.25	0.004	-	0.010	
D	1.80	2.00	2.20	0.071	0.079	0.087	
Е	1.80	2.10	2.40	0.071	0.083	0.094	
E ₁	1.15	1.25	1.35	0.045	0.049	0.053	
е	0.65BSC			0.026BSC			
e ₁	1.20	1.30	1.40	0.047	0.051	0.055	
L	0.10	0.20	0.30	0.004	0.008	0.012	
۵	7°Nom			7°Nom			
ECN: S-03946—Rev. C, 09-Jul-01 DWG: 5549							



RECOMMENDED MINIMUM PADS FOR SC-70: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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